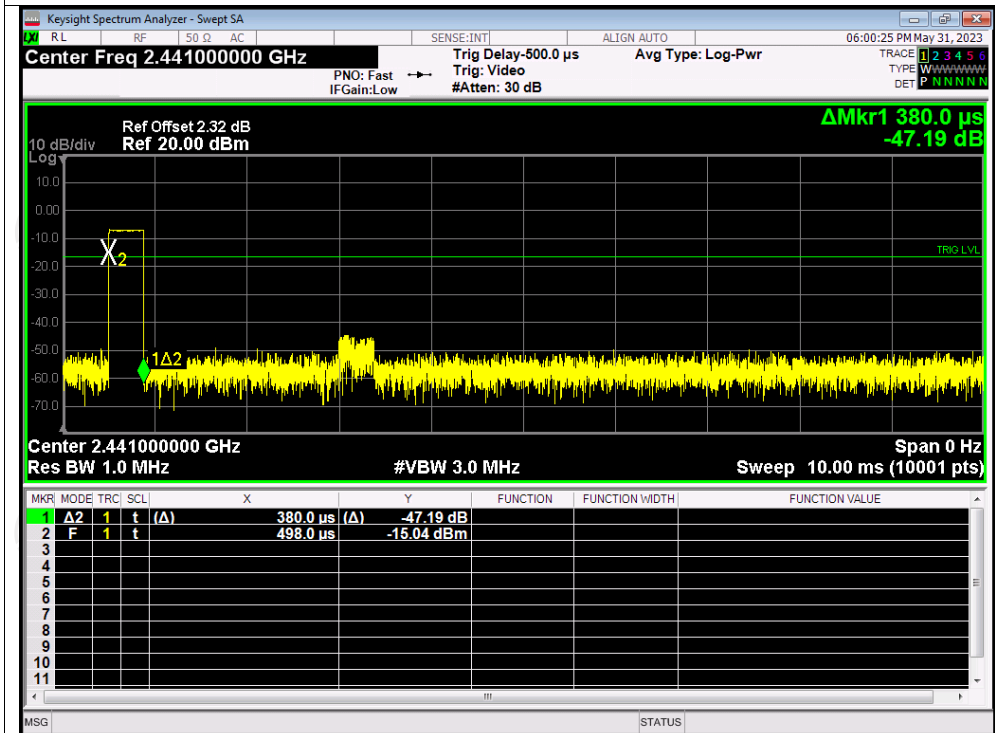


Dwell Time

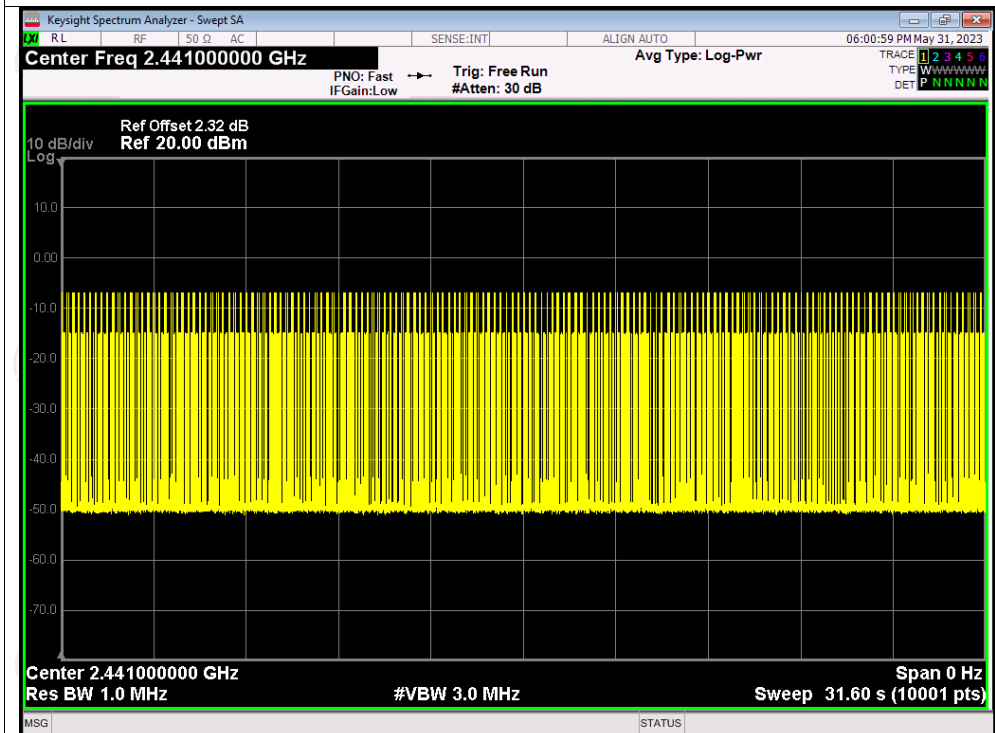
Condition	Mode	Frequency (MHz)	Pulse Time (ms)	Total Dwell Time (ms)	Burst Count	Period Time (ms)	Limit (ms)	Verdict
NVNT	1-DH1	2441	0.38	120.46	317	31600	400	Pass
NVNT	1-DH3	2441	1.63	259.17	159	31600	400	Pass
NVNT	1-DH5	2441	2.88	290.88	101	31600	400	Pass
NVNT	2-DH1	2441	0.39	121.68	312	31600	400	Pass
NVNT	2-DH3	2441	1.64	260.76	159	31600	400	Pass
NVNT	2-DH5	2441	2.88	302.40	105	31600	400	Pass
NVNT	3-DH1	2441	0.38	120.08	316	31600	400	Pass
NVNT	3-DH3	2441	1.64	254.20	155	31600	400	Pass
NVNT	3-DH5	2441	2.89	294.78	102	31600	400	Pass

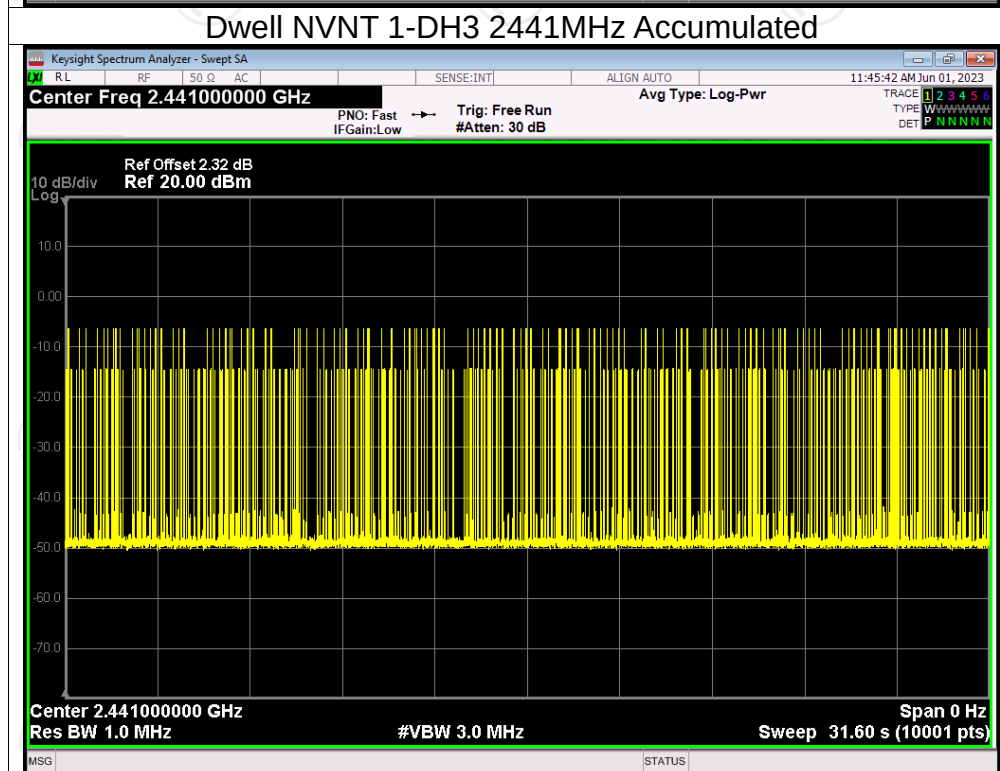
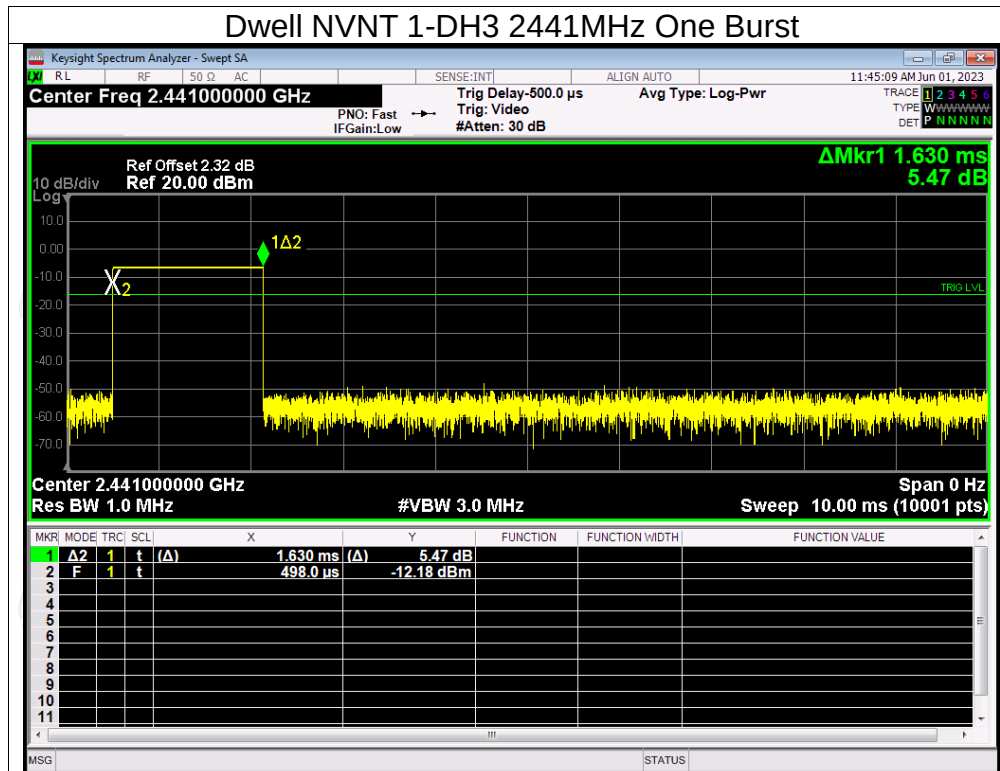
Test Graphs

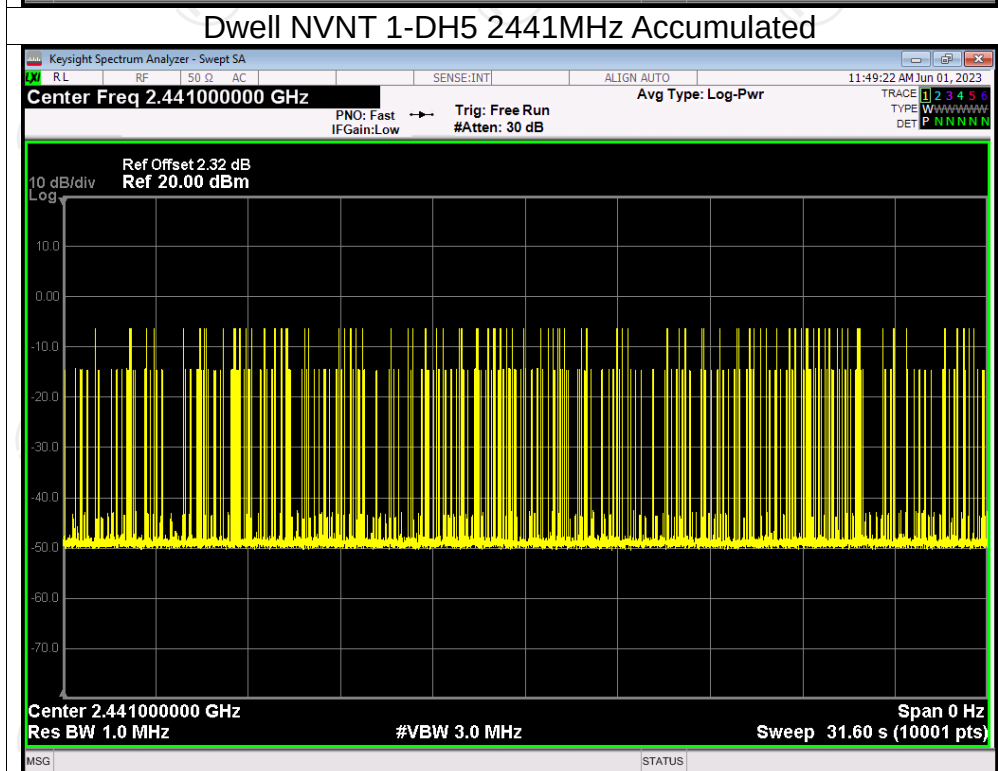
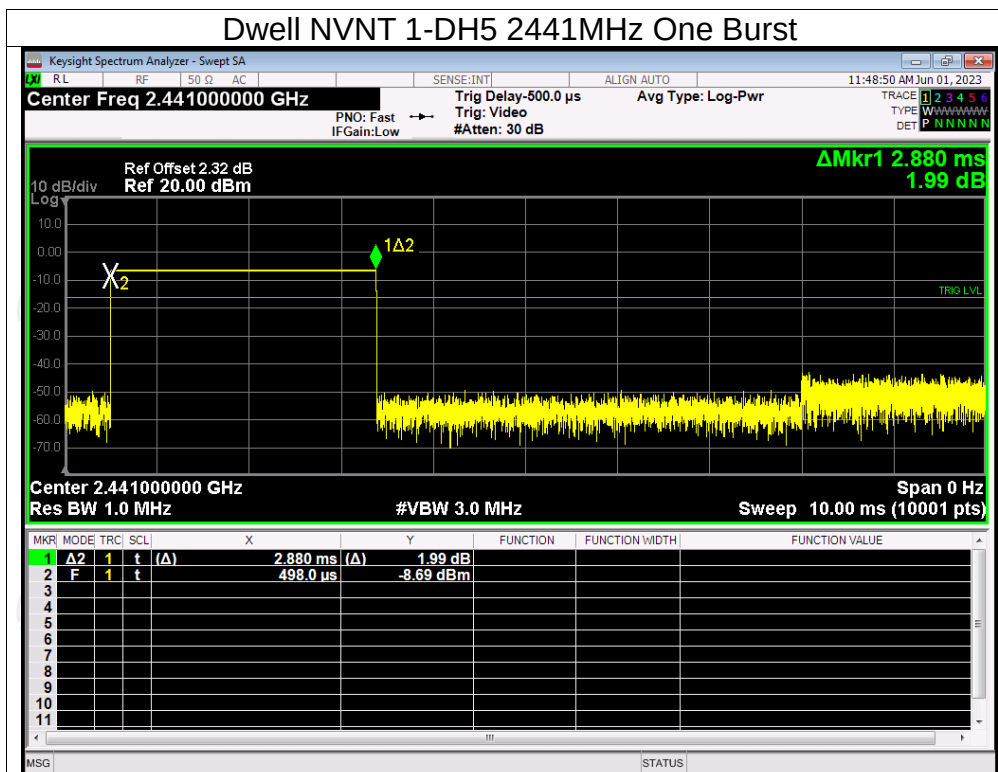
Dwell NVNT 1-DH1 2441MHz One Burst



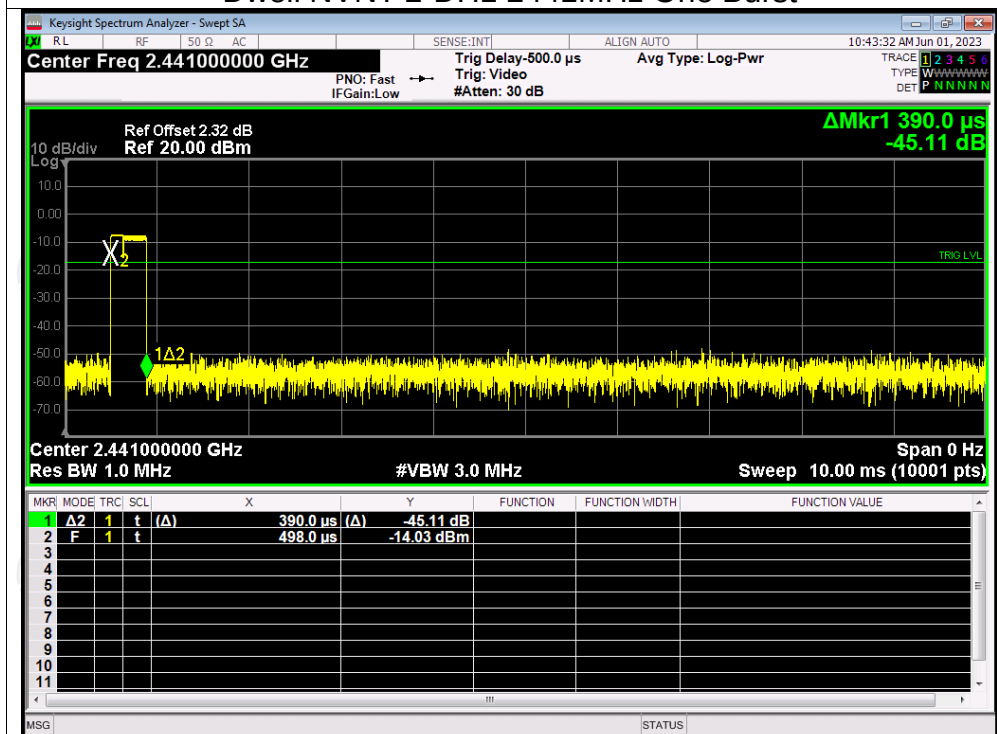
Dwell NVNT 1-DH1 2441MHz Accumulated



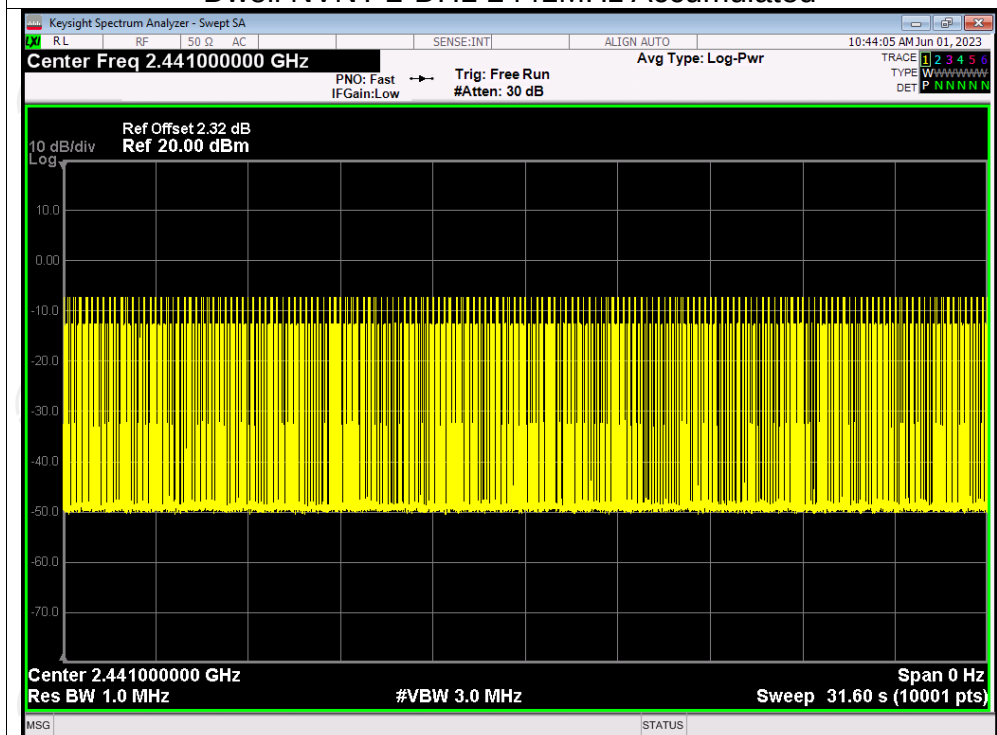


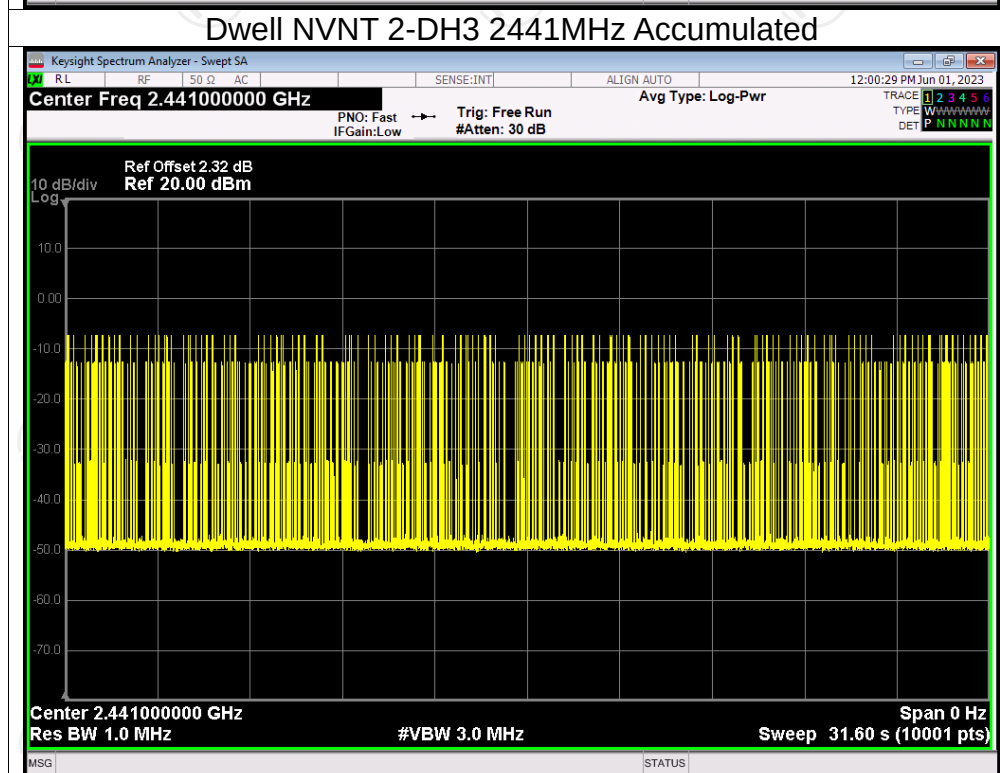
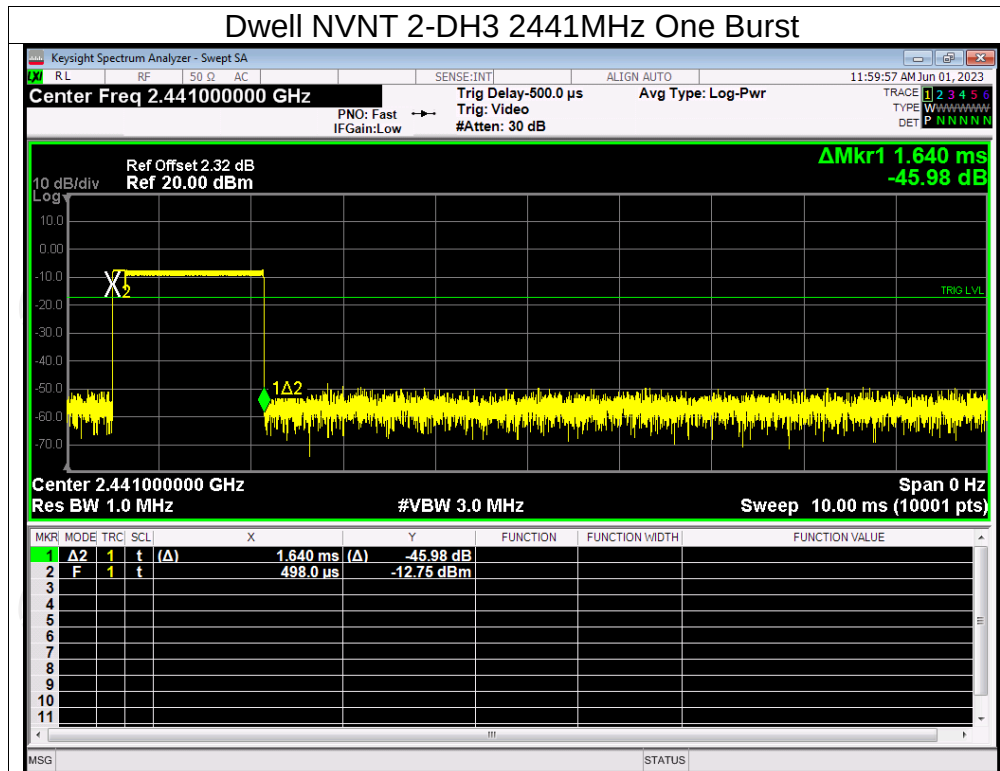


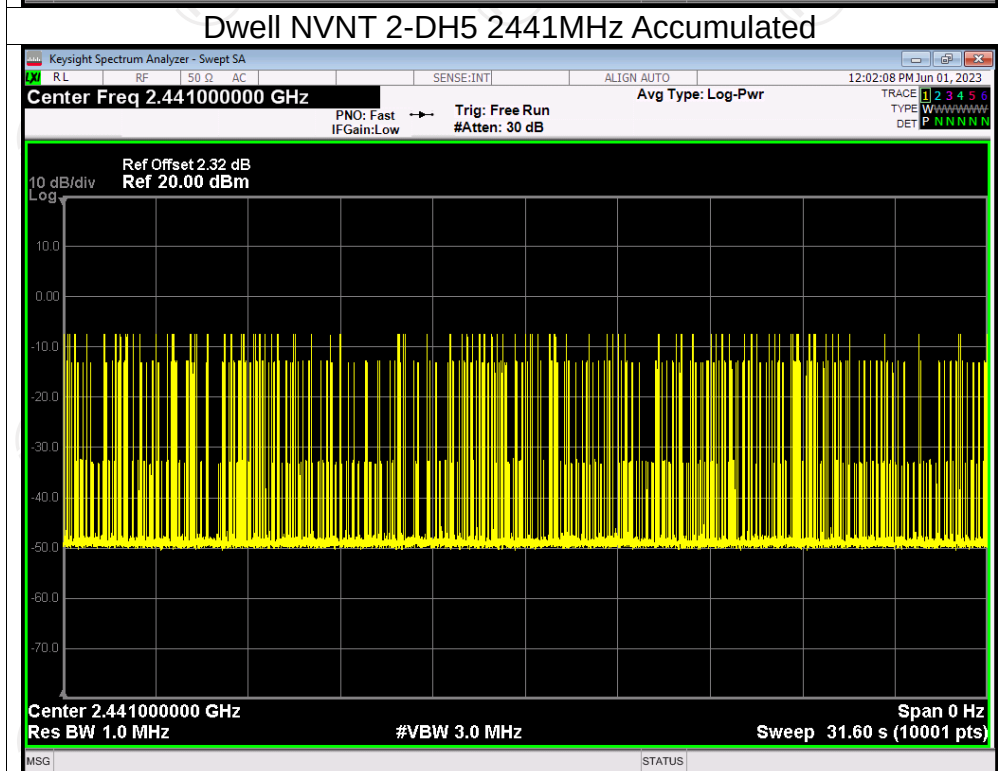
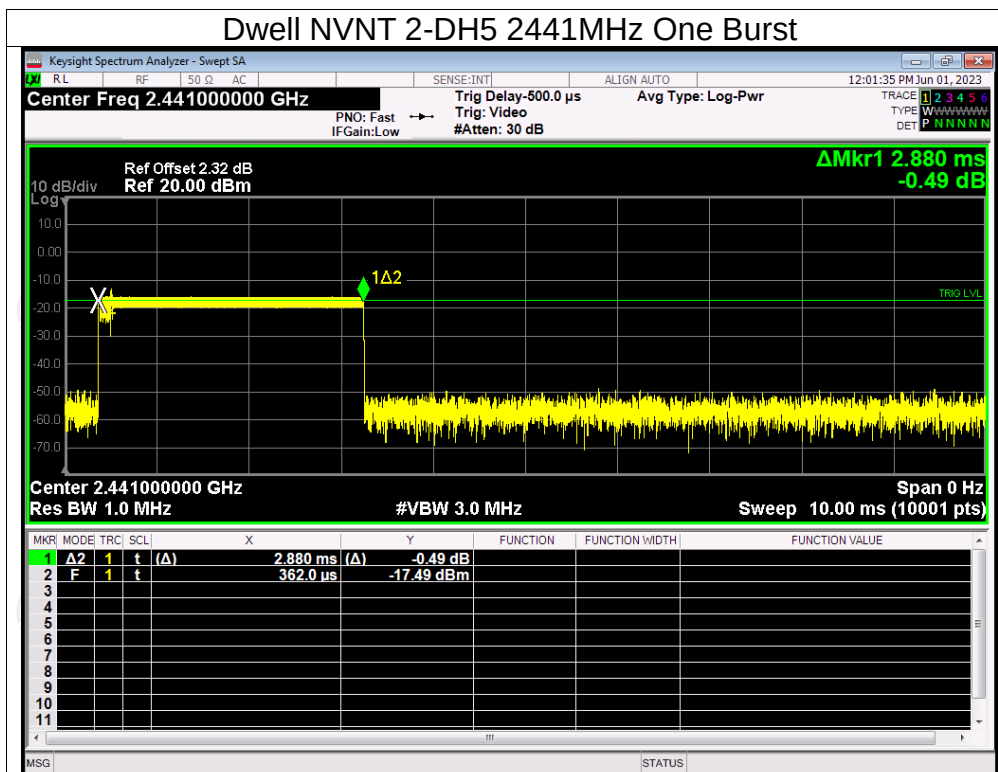
Dwell NVNT 2-DH1 2441MHz One Burst



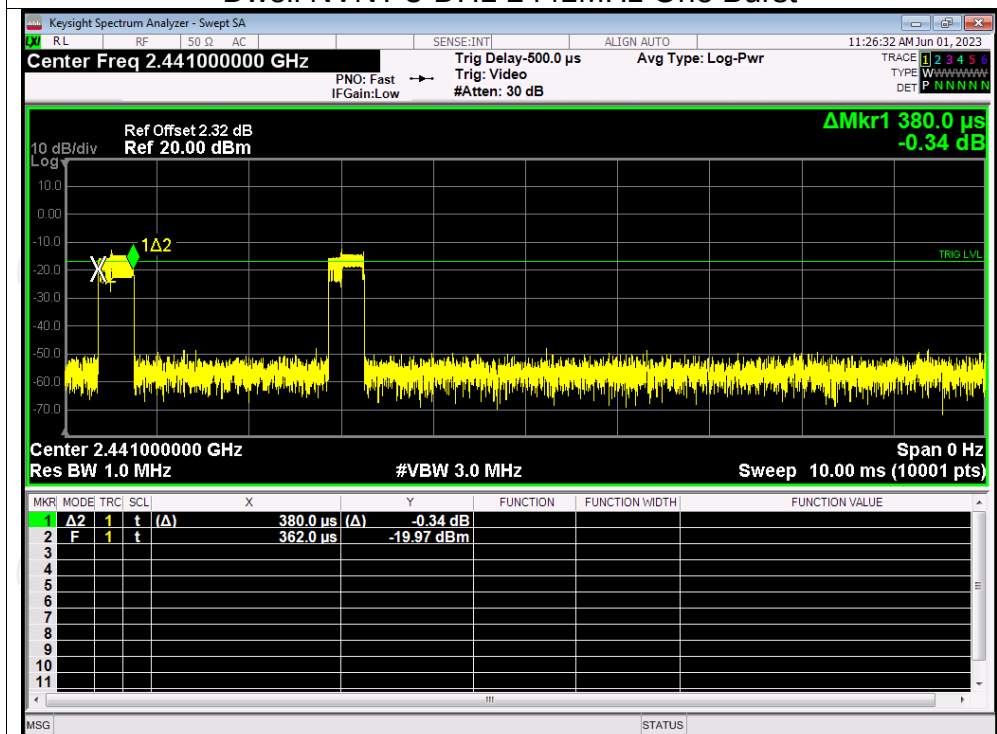
Dwell NVNT 2-DH1 2441MHz Accumulated



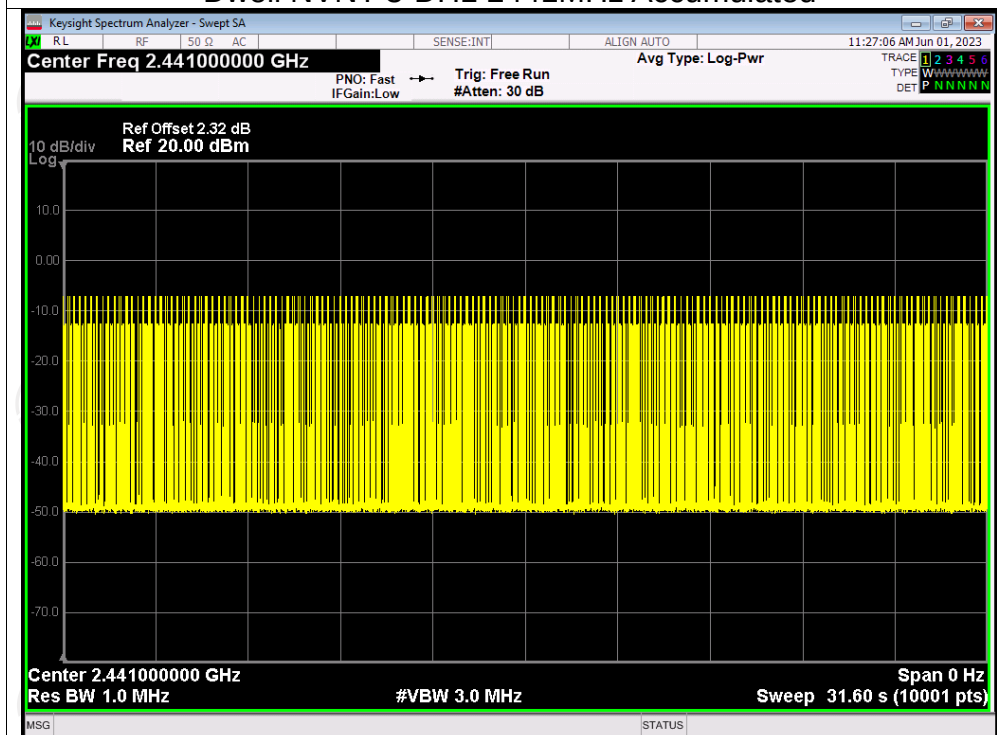


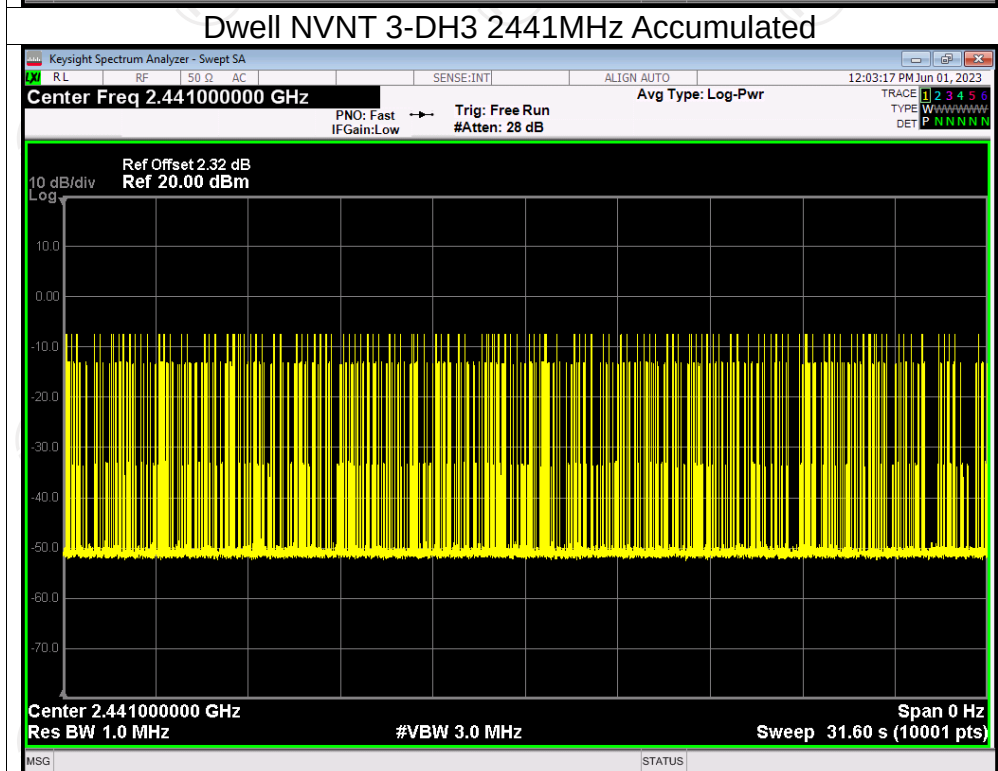
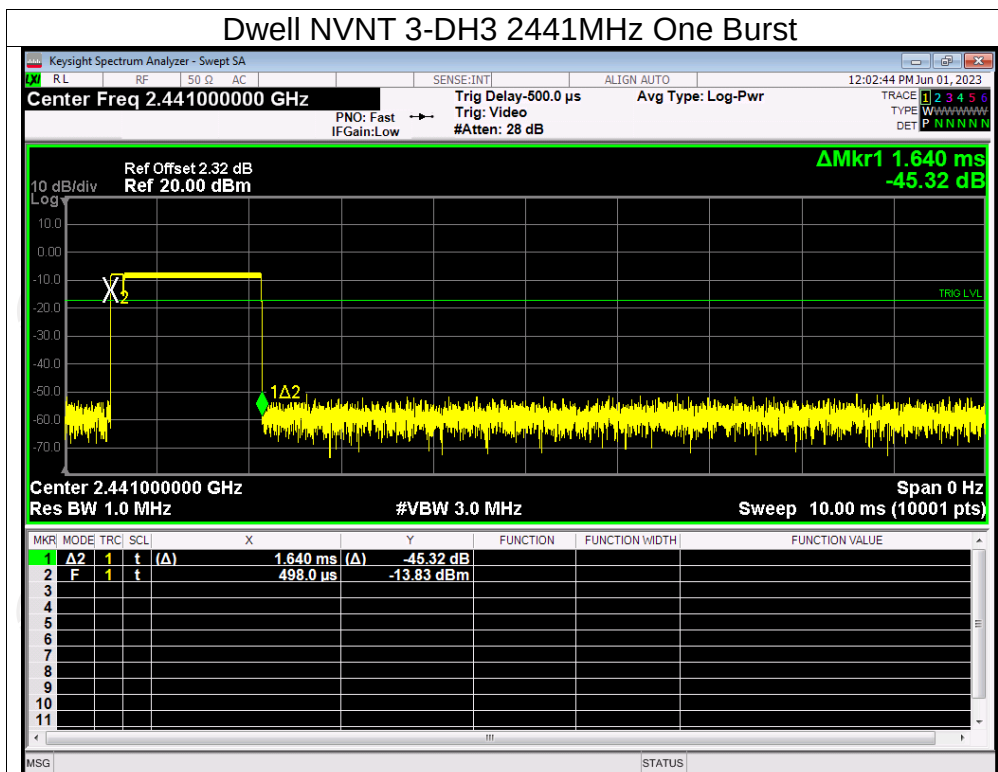


Dwell NVNT 3-DH1 2441MHz One Burst

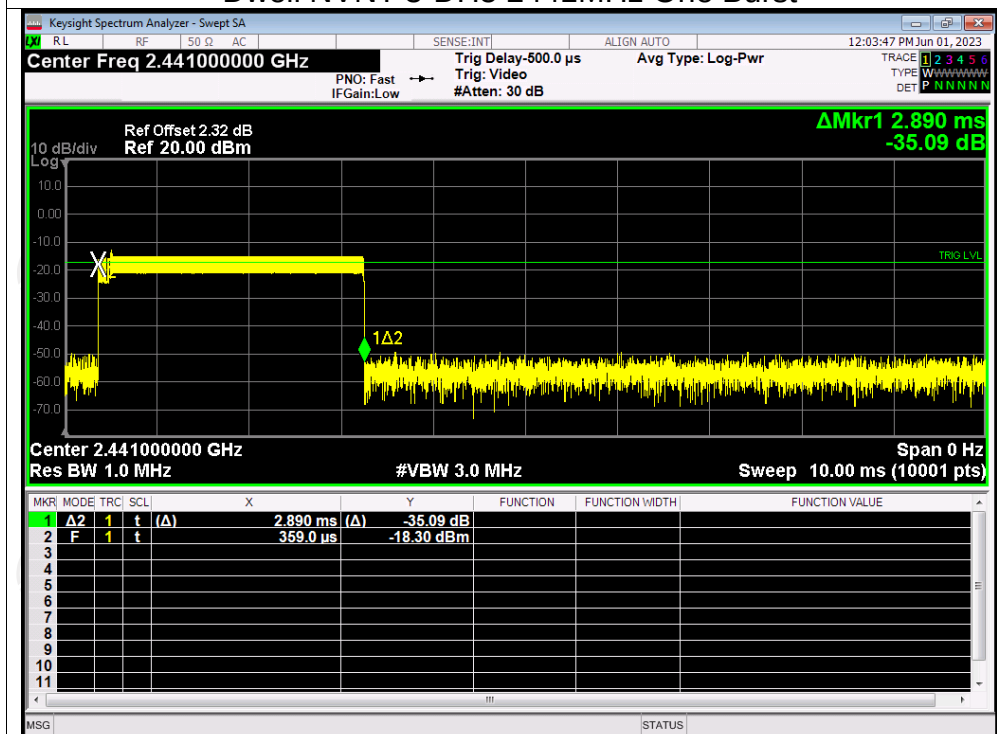


Dwell NVNT 3-DH1 2441MHz Accumulated

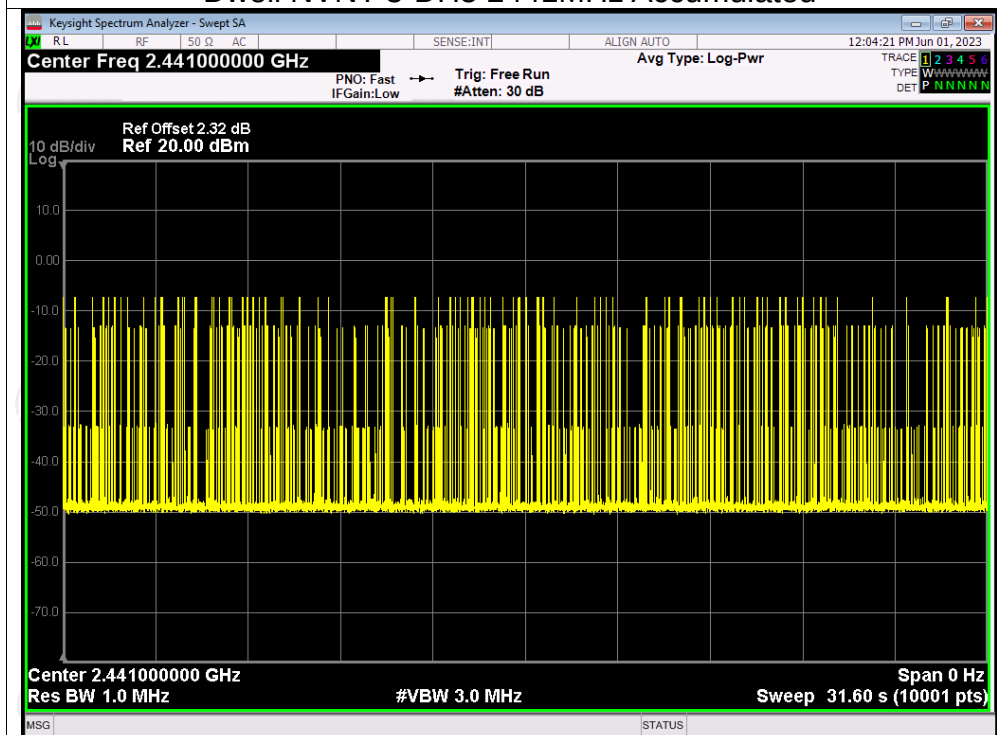




Dwell NVNT 3-DH5 2441MHz One Burst



Dwell NVNT 3-DH5 2441MHz Accumulated

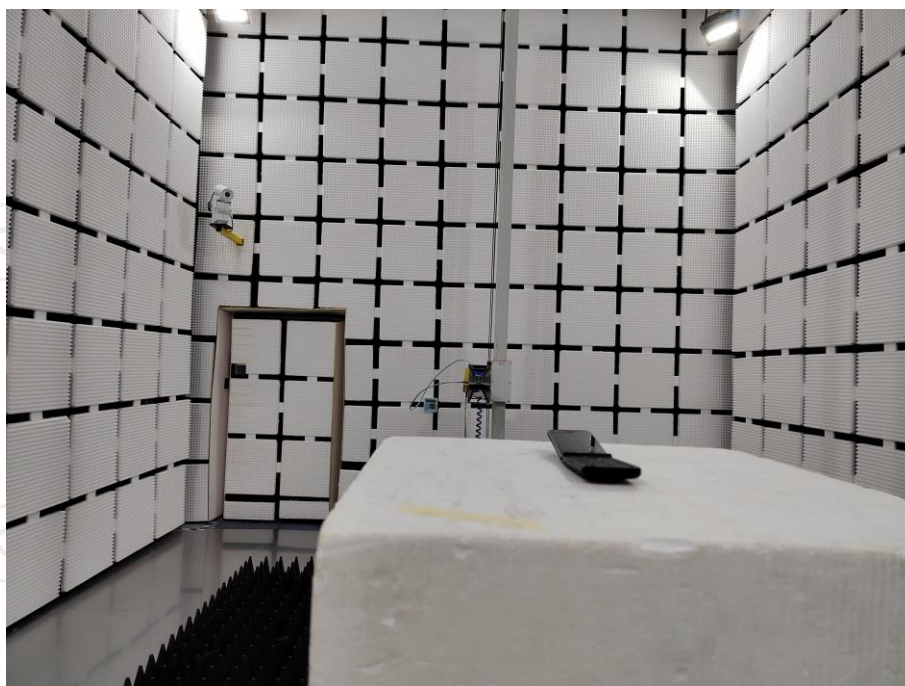
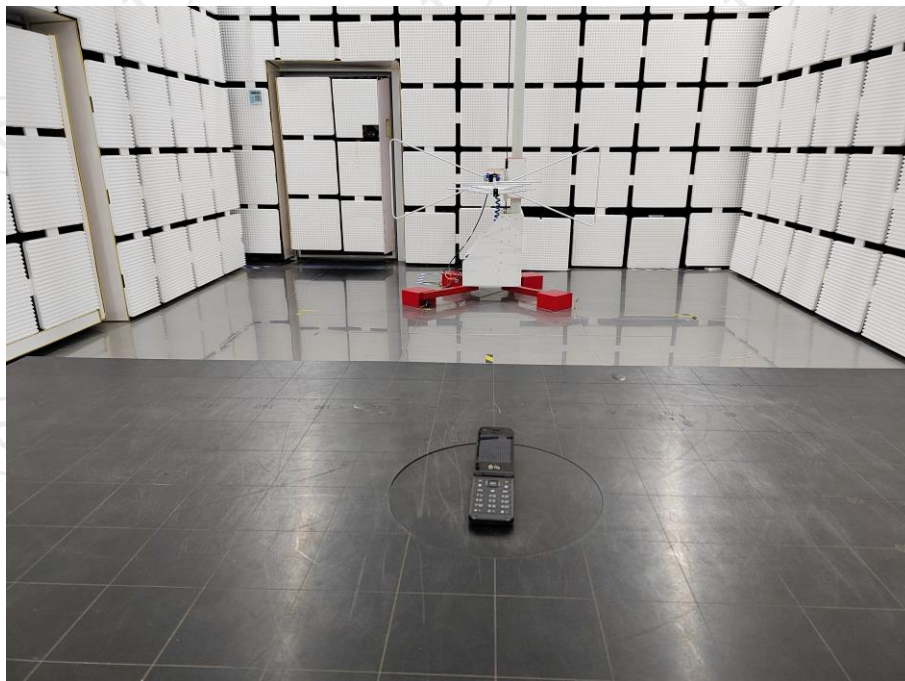


Appendix B: Photographs of Test Setup

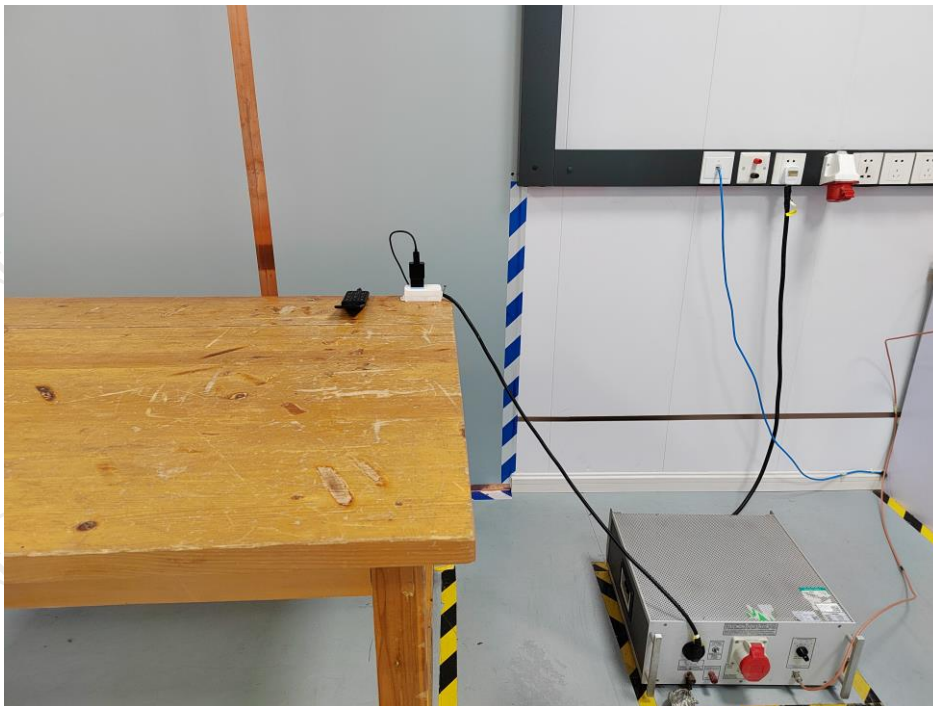
Product: Mobile Phone

Model: F45

Radiated Emission



Conducted Emission



Appendix C: Photographs of EUT

Product: Mobile Phone

Model: F45

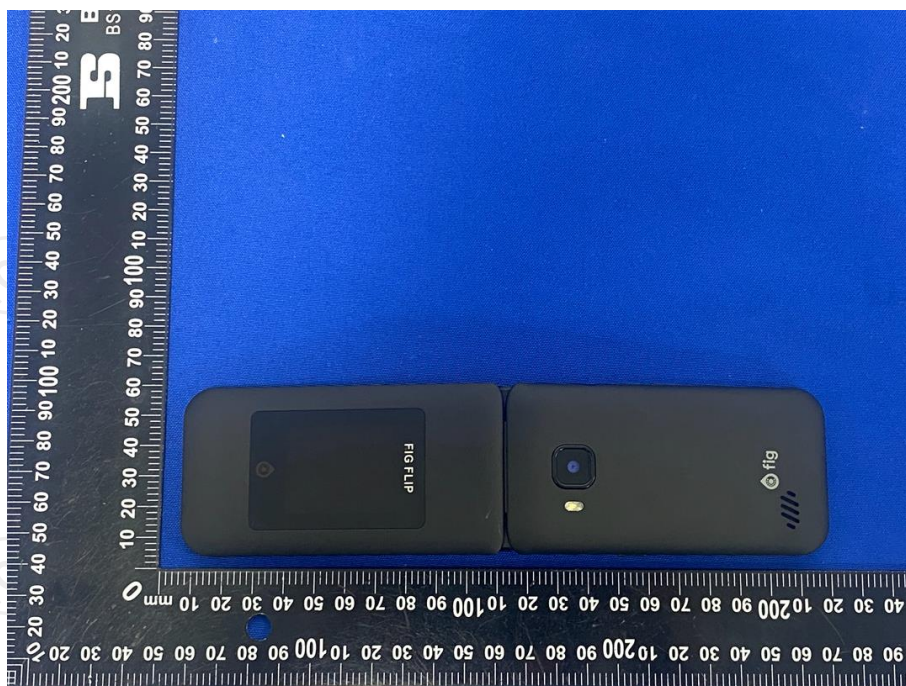
External Photos



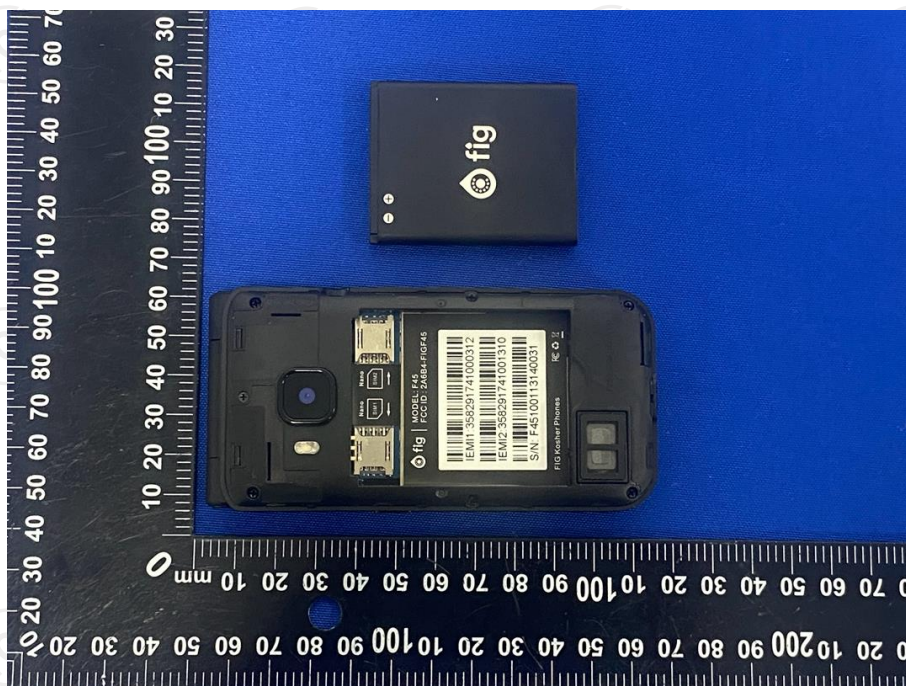


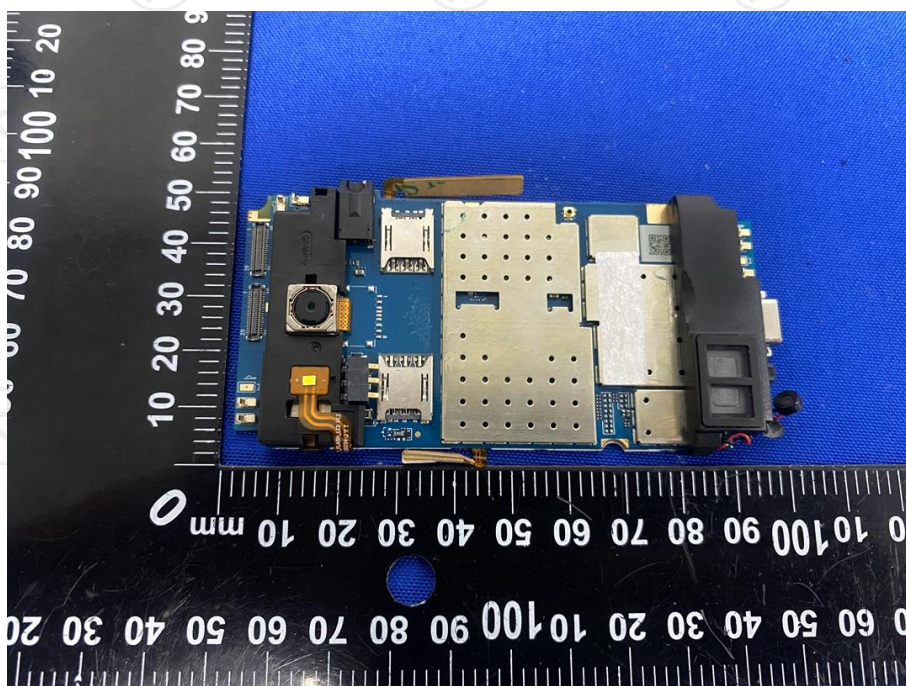
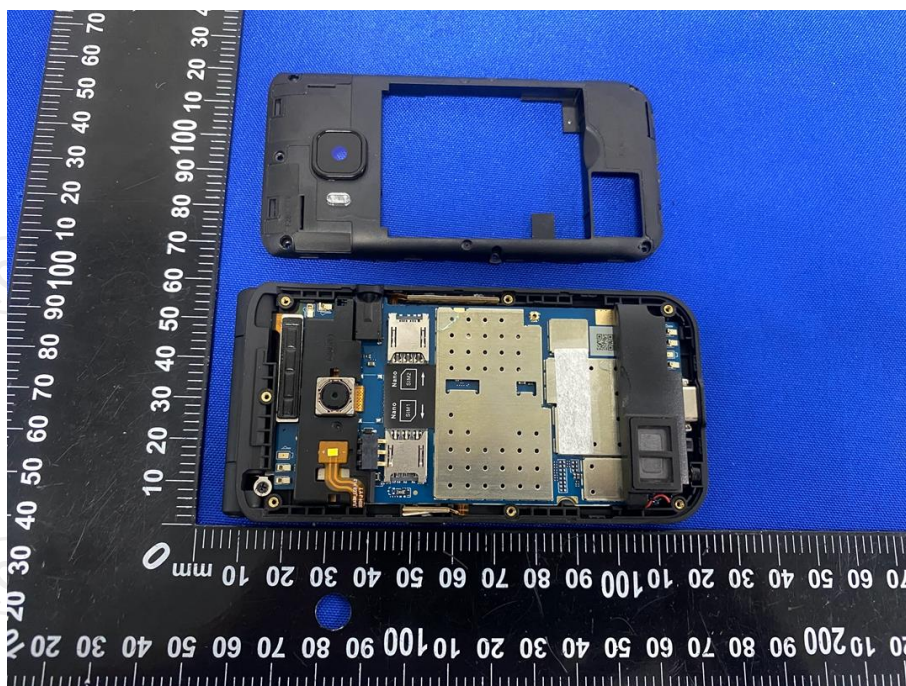


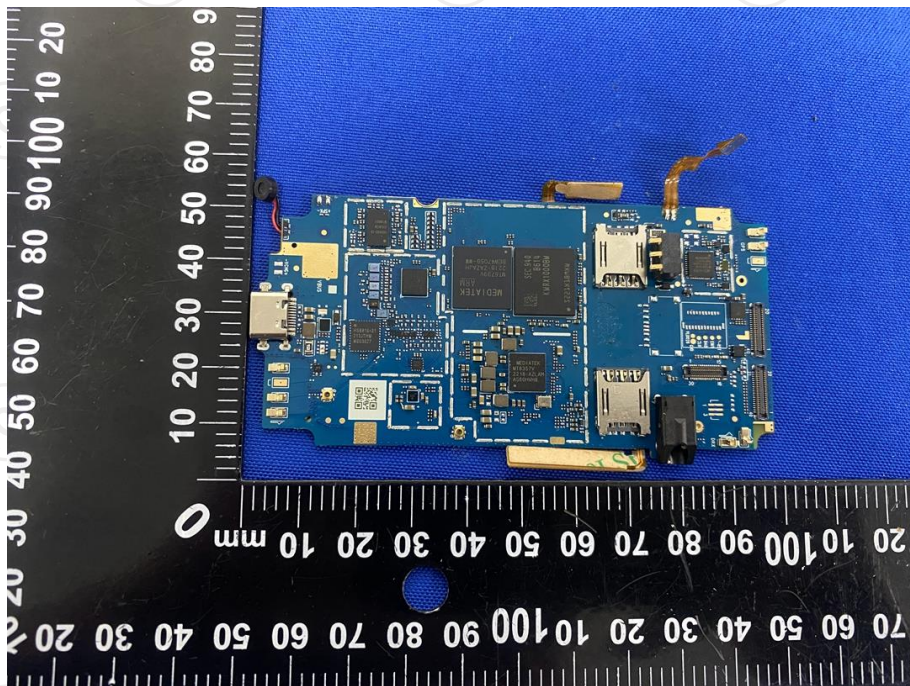
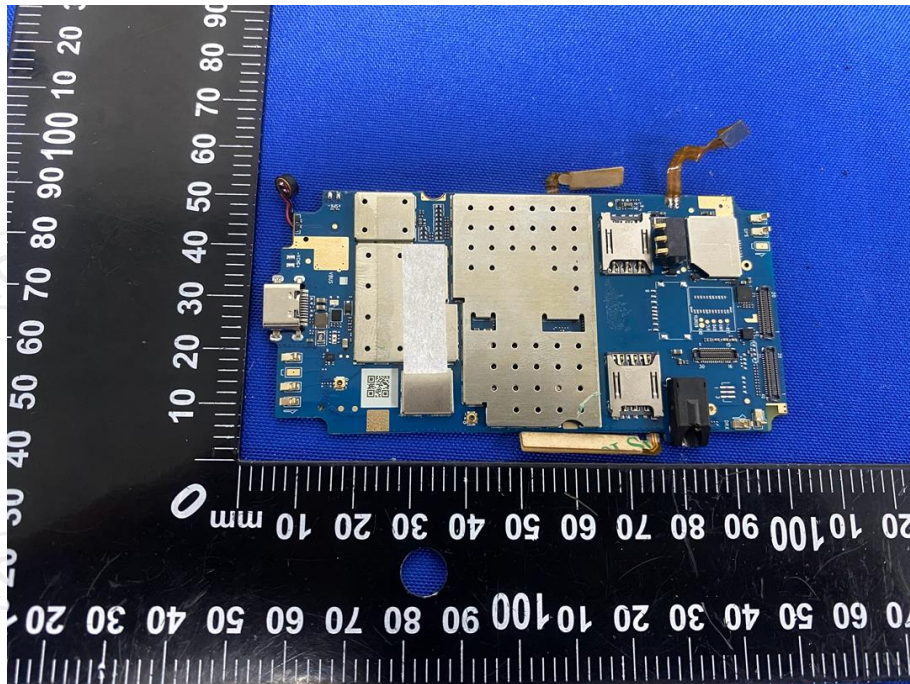


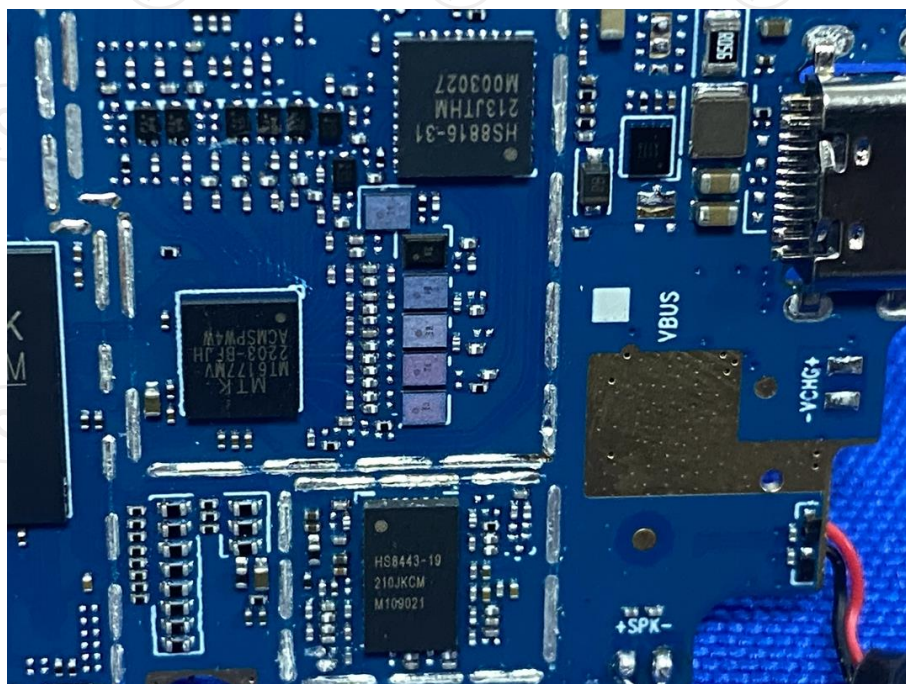
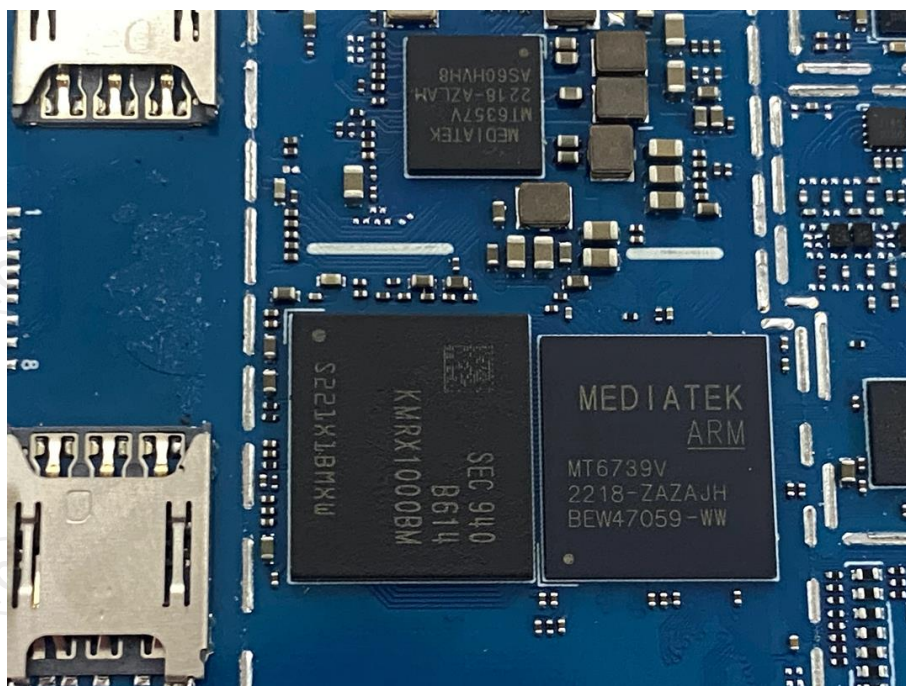


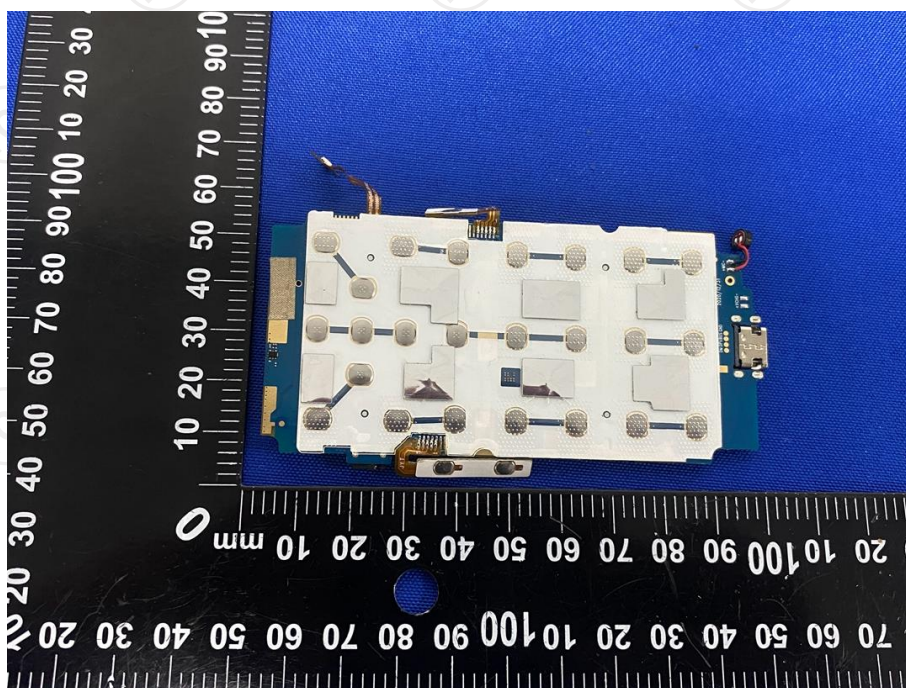
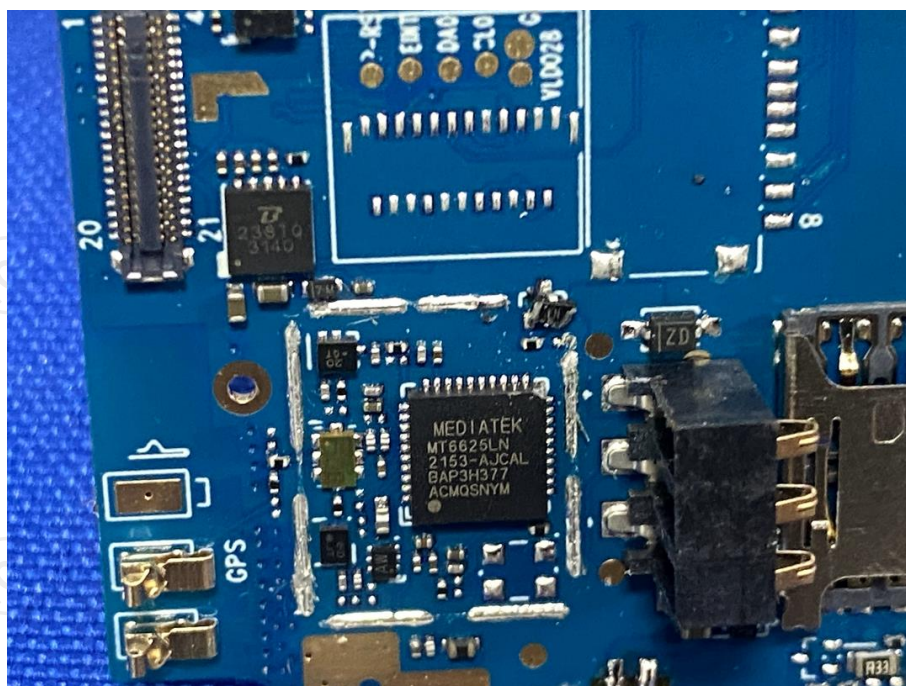
Product: Mobile Phone
Model: F45
Internal Photos

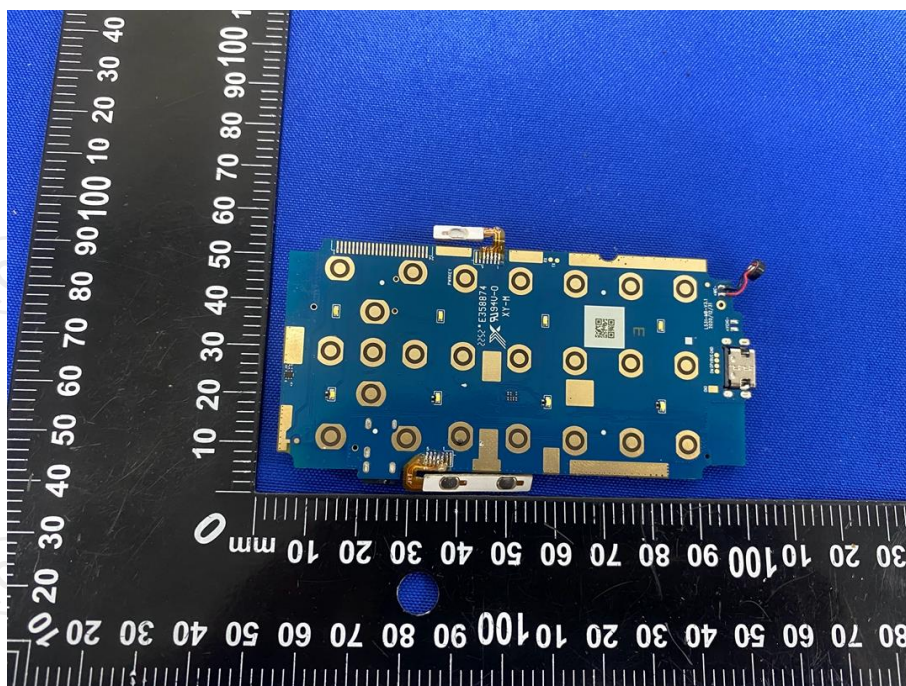


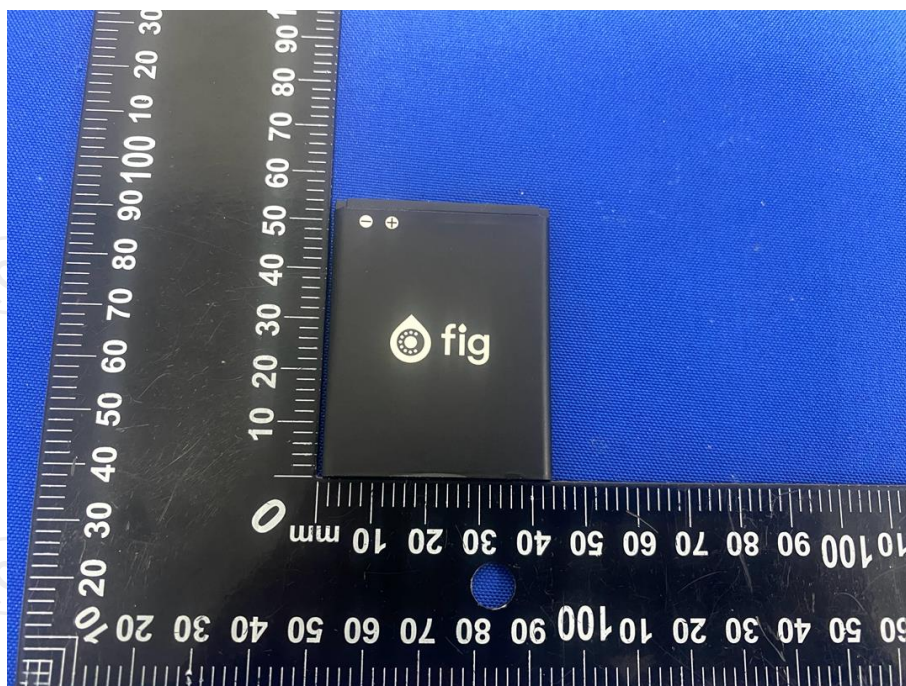












*******END OF REPORT*******